

<b>Notice of References Cited</b>	Application/Control No. 09/838,399	Applicant(s)/Patent Under Reexamination SCHNEIDER, STEVEN	
	Examiner Sargon N Nano	Art Unit 2157	Page 1 of 1

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	C	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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